Searci	n Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/636,181	MIHNEA ET AL.
Examiner	Art Unit
Ly D. Pham	2827

Subclass	Date	Examiner

TNI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1			

DATE	
	EXMR
11/25/2005	LP
11/25/2005	LP